

Search Notes

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Nhan T. Tran

Applicant(s)/Patent under
Reexamination

NOMURA ET AL.

Art Unit

2615

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	1/31/2006	NT
348/\$.ccls. 382/\$.ccls. (text search - see search history printout)	1/31/2006	NT